Notice of References Cited Application/Control No. 10/626,650 Examiner Jeff Piziali Applicant(s)/Patent Under Reexamination YAMASHITA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0104877 A1	05-2005	Nakamura et al.	345/207
	В	US-2003/0179192 A1	09-2003	Allen et al.	345/207
	С	US-6,903,714 B2	06-2005	Tobiya, Akira	345/89
	D	US-6,900,832 B1	05-2005	Yano, Takashi	348/222.1
	Е	US-6,879,096 B1	04-2005	Miyazaki et al.	313/495
	F	US-6,862,029 B1	03-2005	D'Souza et al.	345/690
	G	US-6,717,560 B2	04-2004	Cok et al.	345/82
	Η	US-6,388,648 B1	05-2002	Clifton et al.	345/88
	-	US-5,510,851 A	04-1996	Foley et al.	348/658
	J	US-5,115,229 A	05-1992	Shalit, Hanoch	345/2.2
	К	US-4,989,072 A	01-1991	Sato et al.	348/180
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					·
	Р					
	a					
	R					
	S					
	Т	•				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.